

IGBT Module**Sixpack**

Short Circuit SOA Capability

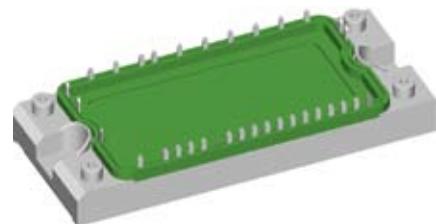
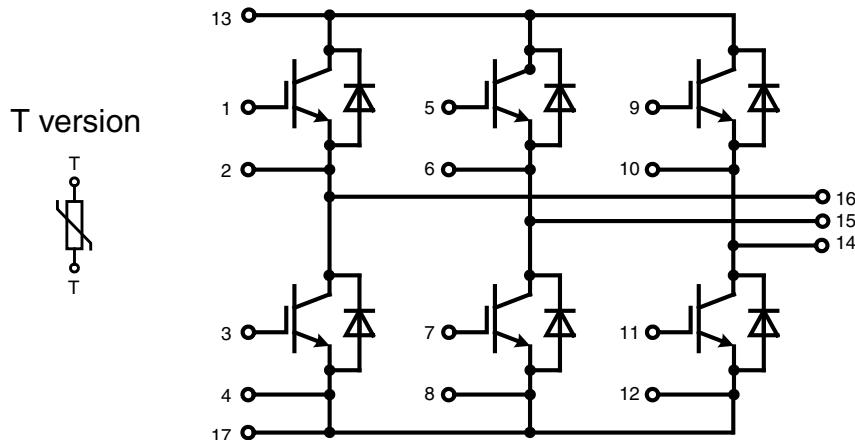
Square RBSOA

I_{C25} = 50 A
 V_{CES} = 1200 V
 $V_{CE(sat)\ typ.}$ = 2.2 V

Part name (Marking on product)

MWI25-12A7

MWI25-12A7T



E72873

Pin configuration see outlines.

Features:

- NPT IGBT technology
- low saturation voltage
- positive temperature coefficient for easy paralleling
- low switching losses
- switching frequency up to 30 kHz
- square RBSOA, no latch up
- high short circuit capability
- MOS input, voltage controlled
- ultra fast free wheeling diodes
- solderable pins for PCB mounting
- space savings
- reduced protection circuits

Application:

- AC motor control
- AC servo and robot drives power supplies

Package:

- UL registered
- Industry standard E2-pack
- package with copper base plate
- package designed for wave soldering

IGBTs

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ\text{C}$ to 150°C		1200		V
V_{GES}	max. DC gate voltage	continuous		± 20		V
V_{GEM}	max. transient collector gate voltage	transient		± 30		V
I_{C25}	collector current	$T_c = 25^\circ\text{C}$	50			A
I_{C80}		$T_c = 80^\circ\text{C}$	35			A
P_{tot}	total power dissipation	$T_c = 25^\circ\text{C}$	225			W
$V_{CE(sat)}$	collector emitter saturation voltage	$I_c = 25 \text{ A}; V_{GE} = 15 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	2.2 2.6	2.7	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_c = 1 \text{ mA}; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ\text{C}$	4.5	6.5	V
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	2	2	mA mA
I_{GES}	gate emitter leakage current	$V_{CE} = 0 \text{ V}; V_{GE} = \pm 20 \text{ V}$		200		nA
C_{ies}	input capacitance	$V_{CE} = 25 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz}$		1650		pF
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 \text{ V}; V_{GE} = 15 \text{ V}; I_c = 35 \text{ A}$		120		nC
$t_{d(on)}$	turn-on delay time	$T_{VJ} = 125^\circ\text{C}$	100			ns
t_r	current rise time		70			ns
$t_{d(off)}$	turn-off delay time		500			ns
t_f	current fall time		70			ns
E_{on}	turn-on energy per pulse		3.8			mJ
E_{off}	turn-off energy per pulse		2.8			mJ
I_{CM}	reverse bias safe operating area	$RBSOA; V_{GE} = \pm 15 \text{ V}; R_G = 47 \Omega$ $L = 100 \mu\text{H}$; clamped induct. load $V_{CEmax} = V_{CES} - L_s \cdot di/dt$	$T_{VJ} = 125^\circ\text{C}$	70		A
t_{sc} (SCSOA)	short circuit safe operating area	$V_{CE} = V_{CES}; V_{GE} = \pm 15 \text{ V}; R_G = 47 \Omega$; non-repetitive	$T_{VJ} = 125^\circ\text{C}$	10		μs
R_{thJC}	thermal resistance junction to case	(per IGBT)		0.55		K/W

Diodes

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 150^\circ\text{C}$		1200		V
I_{F25}	forward current	$T_c = 25^\circ\text{C}$	50			A
I_{F80}		$T_c = 80^\circ\text{C}$	33			A
V_F	forward voltage	$I_F = 25 \text{ A}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$	2.3 1.7	2.7	V V
I_{RM}	max. reverse recovery current	$T_{VJ} = 125^\circ\text{C}$	20			A
t_{rr}	reverse recovery time		200			ns
$E_{rec(off)}$	reverse recovery energy		1.3			mJ
R_{thJC}	thermal resistance junction to case	(per diode)		1.19		K/W

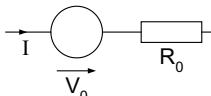
 $T_c = 25^\circ\text{C}$ unless otherwise stated

Module

Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
T_{VJ}	<i>operating temperature</i>		-40		125	°C
T_{VJM}	<i>max. virtual junction temperature</i>				150	°C
T_{stg}	<i>storage temperature</i>		-40		125	°C
V_{ISOL}	<i>isolation voltage</i>	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			2500	V~
M_d	<i>mounting torque</i>	(M4)	2.7		3.3	Nm
d_s	<i>creep distance on surface</i>		6			mm
d_A	<i>strike distance through air</i>		6			mm
Weight				180		g
R_{thCH}	<i>thermal resistance case to heatsink</i>	with heatsink compound	0.02			K/W

Temperature Sensor NTC

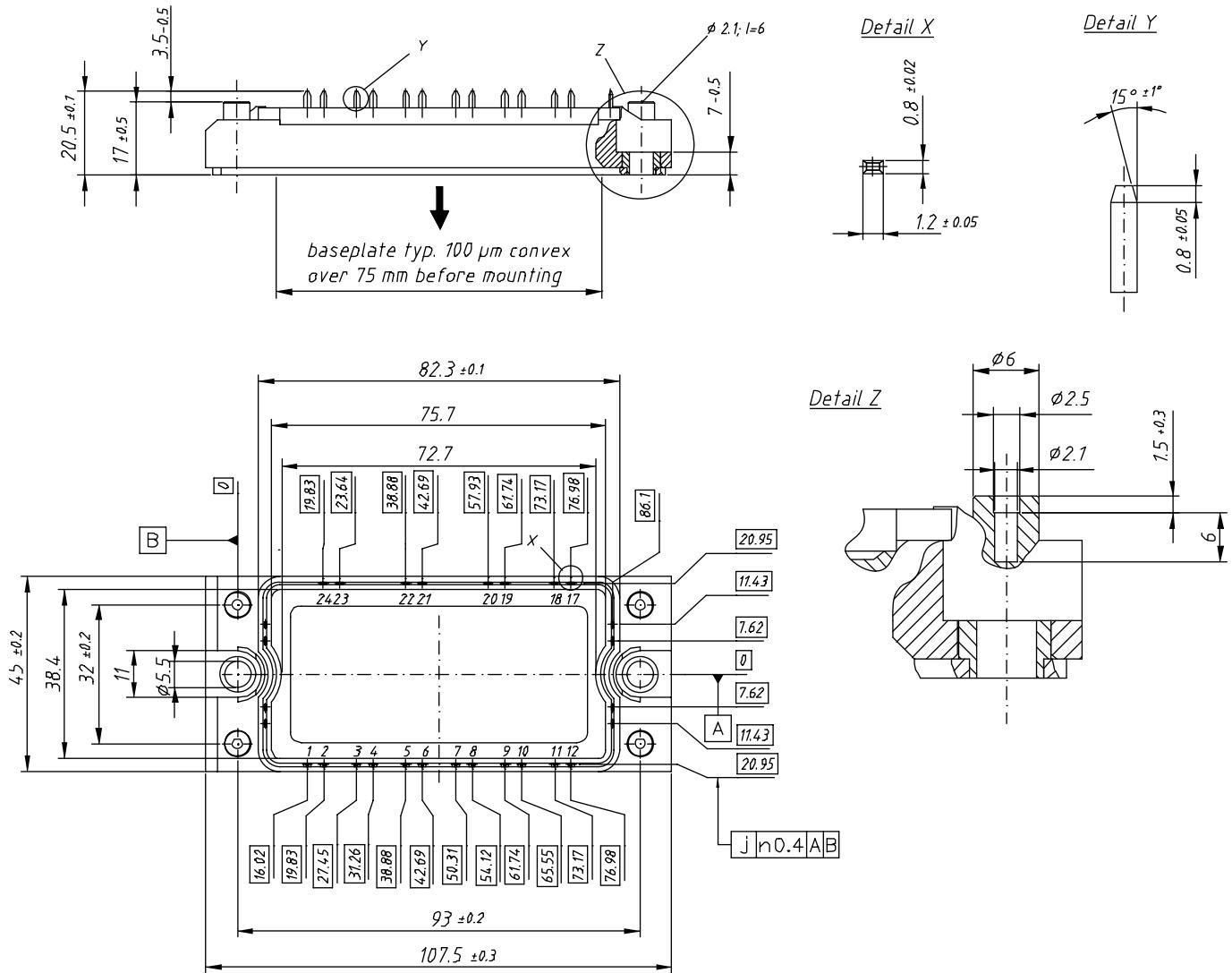
Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	<i>resistance</i>			$T_c = 25^\circ\text{C}$	4.75	5.0
$B_{25/50}$					3375	5.25 K

Equivalent Circuits for Simulation**Ratings**

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_0	<i>IGBT</i>	$T1 - T6$		$T_{VJ} = 125^\circ\text{C}$	1.5 40.7	V mΩ
R_0						
V_0	<i>Diode</i>	$D1 - D6$		$T_{VJ} = 125^\circ\text{C}$	1.3 16	V mΩ
R_1						
R_2						
C_1						
C_2						
			$Z_{th}(t) = \sum_{i=1}^n \left[R_i \cdot \left(1 - \exp\left(-\frac{t}{\tau_i}\right) \right) \right]$ $\tau_i = R_i \cdot C_i$		IGBT	Diode

Outline Drawing

Dimensions in mm (1 mm = 0.0394")



Product Marking

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MWI 15-12A7	MWI15-12A7	Box	10	482730
Standard	MWI 15-12A7T	MWI15-12A7T	Box	10	480819

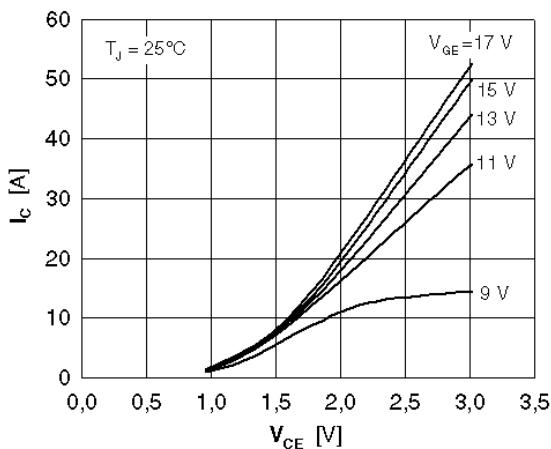


Fig. 1 Typ. output characteristics

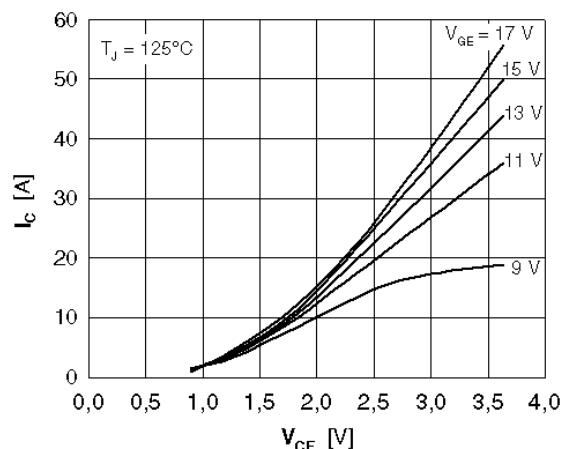


Fig. 2 Typ. output characteristics

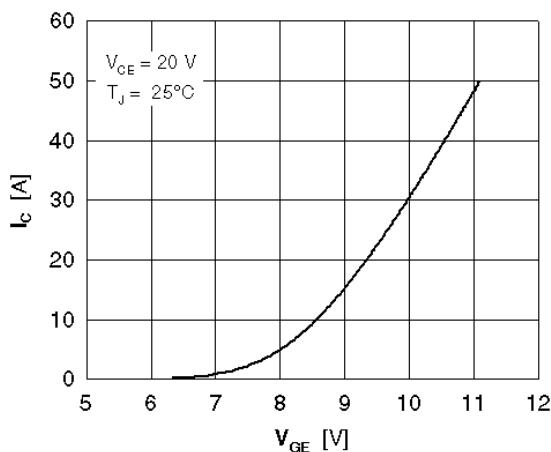


Fig. 3 Typ. transfer characteristics

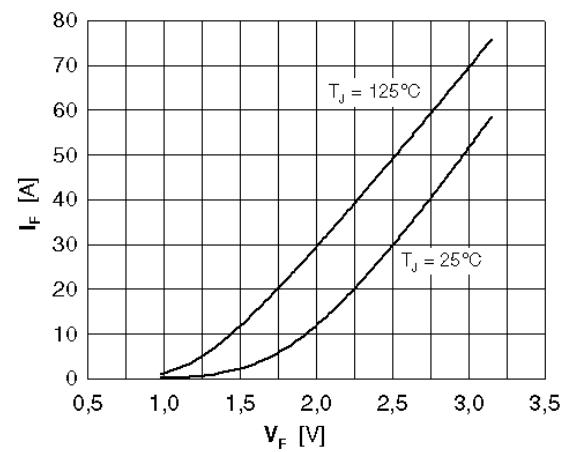


Fig. 4 Typ. forward characteristics of free wheeling diode

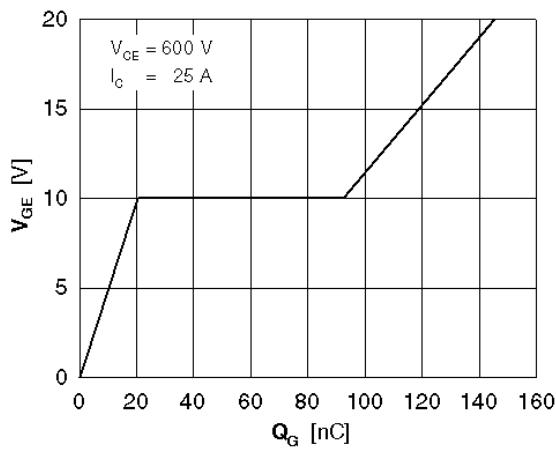


Fig. 5 Typ. turn on gate charge

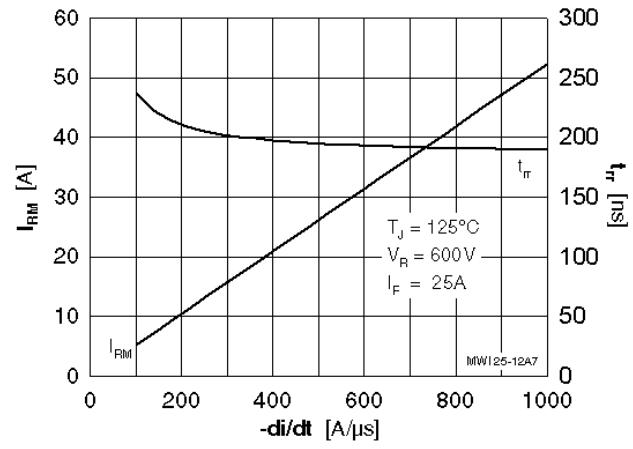


Fig. 6 Typ. turn off characteristics of free wheeling diode

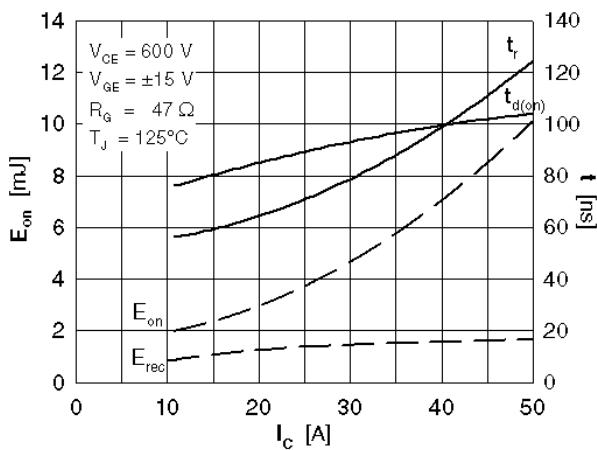


Fig. 7 Typ. turn on energy and switching times versus collector current

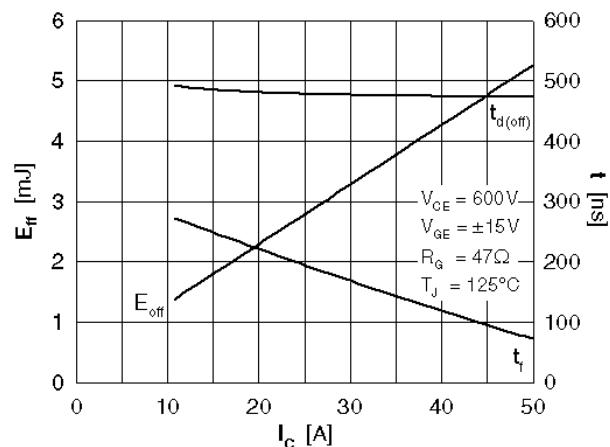


Fig. 8 Typ. turn off energy and switching times versus collector current

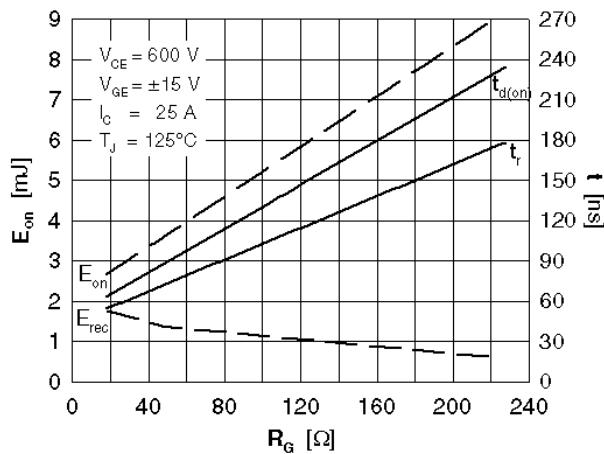


Fig. 9 Typ. turn on energy and switching times versus gate resistor

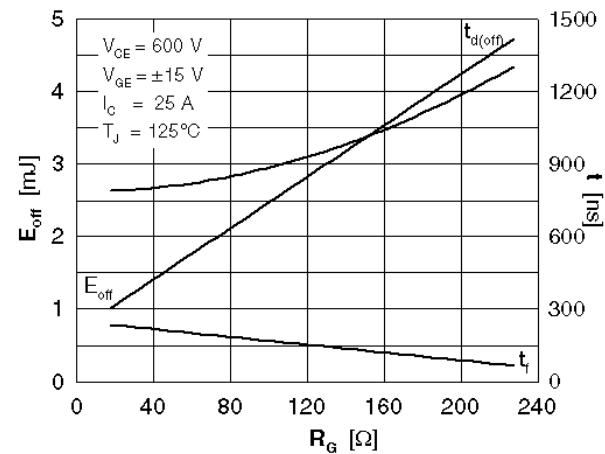


Fig. 10 Typ. turn off energy and switching times versus gate resistor

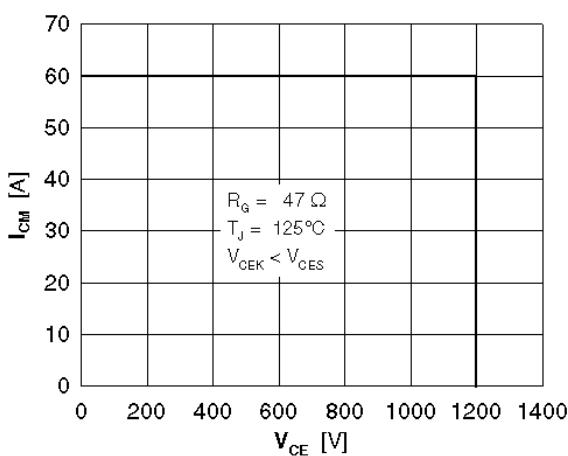


Fig. 11 Reverse biased safe operating area

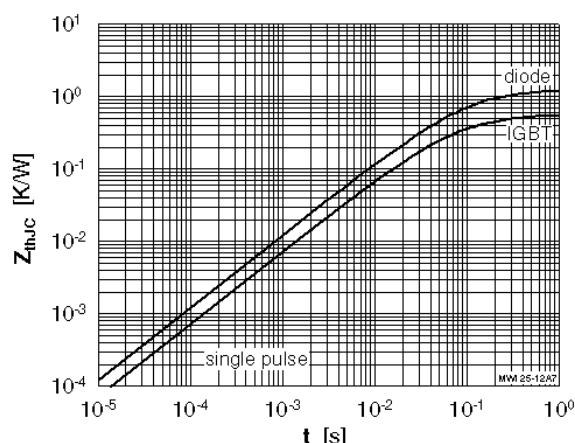


Fig. 12 Typ. transient thermal impedance